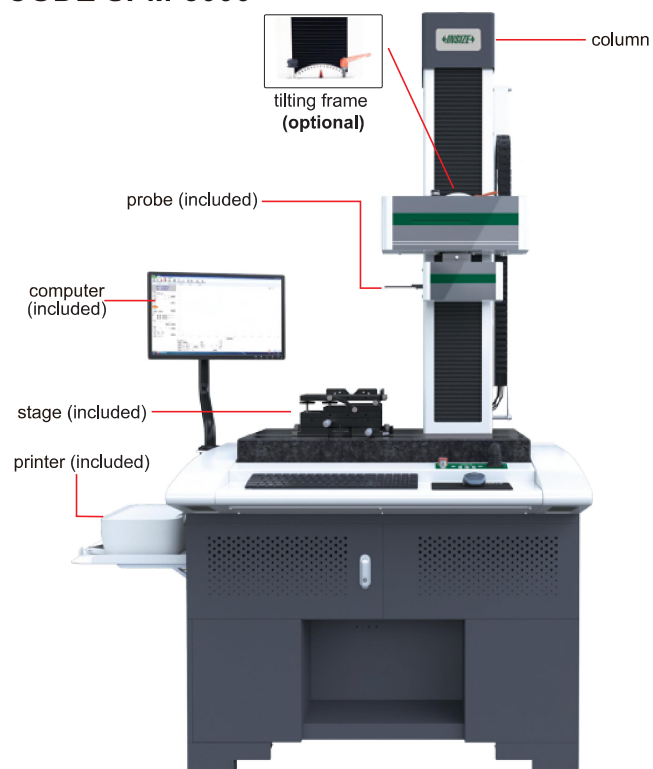


ROUGHNESS AND PROFILE MEASURING MACHINE (ONE PROBE TYPE) CODE SPM-5000

PROFILE AND ROUGHNESS
MEASUREMENT AT THE SAME TIME



- Roughness, waviness, and profile analysis can be achieved with just one measurement
- Can measure all roughness and waviness parameters
- Can be used for automatic measurement system
- Air flotation and shockproof system to reduce measurement deviation
- Free to edit measurement reports

PROFILE MEASUREMENT SPECIFICATION

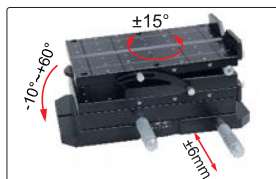
X axis measuring range	150mm
X axis resolution	0.0012μm
X axis traverse speed	(0.05~20)mm/s
X axis linear accuracy	$\pm(0.8+ 0.015L)\mu\text{m}$, L is measuring length in mm
Z axis measuring range	$\pm 10\text{mm}$
Z axis resolution	0.0012μm
Z axis traverse speed	(0.2~40)mm/s
Z axis linear accuracy	$\pm(0.5+ 0.02H)\mu\text{m}$, H is measuring height in mm
Angular measuring accuracy	$\pm 1'$
Arc measuring accuracy	$\pm(1+R/12)\mu\text{m}$, R is 2~10mm standard ball
Straightness	0.3μm/100mm
Measuring unit	mm/inch
Travel of Z axis	420mm
Power supply	220 $\pm$ 10%V, 50Hz
Dimension (L×W×H)	1700×820×1900mm
Net weight	500kg

ROUGHNESS MEASUREMENT SPECIFICATION

Roughness parameters	Ra, Ramax, Ramin, Rasd, Rp, Rpm _{ax} , Rpm _{in} , Rpsd, Rv, Rv _{max} , Rv _{min} , Rv _{sd} , Rz, Rz _{max} , Rz _{min} , Rz _{sd} , R3z, Rc, Rc _{max} , Rc _{min} , Rcsd, Rt, Rq, Rq _{max} , Rq _{min} , Rq _{sd} , Rsk, Rsk _{max} , Rsk _{min} , Rsk _{sd} , Rku, Rk _{max} , Rk _{min} , Rk _{sd} , Rsm, Rsm _{max} , Rsm _{min} , Rsm _{sd} , Rs, RΔa, RΔa _{max} , RΔa _{min} , RΔa _{sd} , RΔq, RΔq _{max} , RΔq _{min} , RΔq _{sd} , Rk, Rpk, Rvk, Mr1, Mr2, Rλa, Rλa _{max} , Rλa _{min} , Rλa _{sd} , Rλq, Rλq _{max} , Rλq _{min} , Rλq _{sd} , Rδc, Rpc, Rmr
Waviness parameters	Wa, Wamax, Wamin, Wasd, Wsa, Wca, Wa08, Wc, Wc _{max} , Wc _{min} , Wc _{sd} , Wt, Wz, Wz _{max} , Wz _{min} , Wz _{sd} , Wp, Wp _{max} , Wp _{min} , Wp _{sd} , Wv, Wv _{max} , Wv _{min} , Wv _{sd} , Wq, Wq _{max} , Wq _{min} , Wq _{sd} , Wsm, Wsm _{max} , Wsm _{min} , Wsm _{sd} , Wsk, Wsk _{max} , Wsk _{min} , Wsk _{sd} , Wku, Wku _{max} , Wku _{min} , Wku _{sd} , WΔq, WΔq _{max} , WΔq _{min} , WΔq _{sd} , Wδc, Wmr
Original profile parameters	Pa, Pt, Pp, Pc, Pv, Pz, Pq, Psm, Psk, Pku, RzJ, Rpq, Rvq, Rmq, Pmr, PΔq, Avh, Hmax, Hmin, Area, Pδc, Tilta
Motif parameters	Ncrx, R, Rx, AR, Nr, Cpm, Sr, Sar, W, Wx, Aw, Wte, Nw, Sw, Saw
Measuring range	$\pm 10\text{mm}$
Resolution	0.0012μm
Linear accuracy	$\leq \pm(6\text{nm}+2.5\%)$
Probe radius/angle	5μm/90°
Cut off	0.025/0.08/0.25/0.8/2.5/8mm
Number of cut-offs	2~7
Measuring unit	μm
Measuring speed	(0.1~2)mm/s



vise (included)



stage (included)



standard blocks (included)



standard shaft (included)

STANDARD DELIVERY

Main unit (including workbench, controller, driver, sensor)	1 pc
Calibration block	1 set
Standard roughness stylus and rod	1 set
Standard profile stylus and rod	1 set
Air flotation and shockproof system	1 set
Stage	1 set
Vise	1 set
Computer	1 pc
Software	1 set
Printer	1 pc
Installation tools	1 set

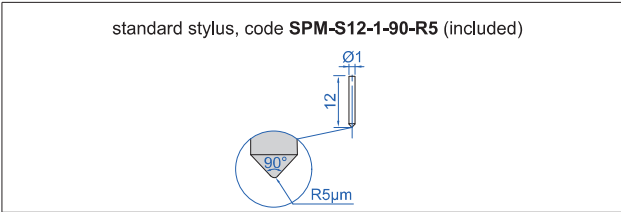
OPTIONAL ACCESSORY

Tilting frame	SPM-1000-TILTING
Stylus and rod*	refer to details

*Reference catalogue (SPM Series): styli and rods for roughness/profile measuring machines

SPECIFICATION OF ROUGHNESS PROBE

unit: mm



SPECIFICATION OF PROFILEPROBES

unit: mm

chisel stylus code SPM-T18-2-17 (optional)	standard stylus rod, code SPM-5000-P1 (included), stylus is not included
cone stylus code SPM-Z18-2-26 (optional)	profile stylus rod, code SPM-5000-P2 (optional), stylus is not included
ball stylus code SPM-5000-S01 (ØS=1mm, optional) code SPM-5000-S02 (ØS=2mm, optional)	profile stylus rod, code SPM-5000-P3 (optional), stylus is not included